

508PV[™] UV-Vis-NIR Microscope Spectrophotometer

Adding Spectroscopy to Your Microscope™

The **508PV**[™] microscope spectrophotometer is a rugged, precision tool designed to be added to an optical microscope. Depending upon the microscope configuration, the 508PV[™] enables you to acquire absorbance, reflectance, fluorescence and even polarization spectra of sub-micron sized samples. It is offered with a spectral range from the deep UV to the near IR as it can also be used to upgrade older model microspectrometers with the latest technologies and software.

The 508PV[™] features Lightblades spectrophotometers, thermoelectric cooling for improved spectral performance, parfocal and parcentral adapters for your microscope and a variable sampling size with absolute reproducibility. Powered by CRAIC Technologies advanced Lambdafire[™] control and analysis software, the 508PV[™] is also able to measure thin film thicknesses in addition to creating 5D spectral maps of samples. The 508PV[™] is flexible, advanced, simple to use and will give years of reliable service.





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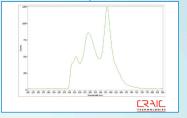
SPECIFICATIONS	
Types of Microspectroscopy	Absorbance, Reflectance, Fluorescence, Kinetics, Polarization
Spectrometer Spectral Range	200-2100 nm*
High Resolution Color Imaging	Included
Fluorescence Excitation	365 - 546 nm
Fluorescence Emission	400 - 900 nm
Spectrometer	Lightblades™
Sampling Area	Variable from 1 to 10,000 microns ²
Reproducible Sampling Areas	Absolute
Detector Cooling	Thermoelectric
Spectral Resolution	User selectable, 1 - 15 nm
Full Spectrum Scan	14 milliseconds
Thin Film Thickness	From as thin as 5 nm
Full Automation	Available
5D Spectral Mapping	Available
Operating System	Windows



Add UV-vis, fluorescence and time resolved spectrocopy to your microscope.



508PV™ adds spectroscopy and film thickness measurements to microscopes, probe stations and older microspectrometers.



Fluorescence emission spectrum of a single textile fiber.

Spectral Range

Calibration Standards

- ☐ Transmittance Standards traceable to NIST
- ☐ Reflectance Standards traceable to NIST
- NIST Raman Standards
- ☐ Vitrinite Coal Reflectance Standards
- ☐ Fluorescence Standards

System Software

- ☐ rlQ™ Glass Refractive Index
- ☐ 5D Spectral Mapping
- ☐ Thin Film Thickness Measurement
- □ TimePro Kinetics™
- □ Colorimetry
- Statistical Analysis

Accessories

- Quartz Slides and Coverslips
- ☐ CRAIC Certified Lamps
- Quartz Wellplates
- ☐ Specular Reflectance Material



Illumination Packages

- ☐ Transmission/Absorbance UV-VIS-NIR
- ☐ Reflectance UV-VIS-NIR
- ☐ Fluorescence UV-VIS-NIR
- ☐ Photoluminescence
- Polarization

Spectrometer Packages

- ☐ Visible-NIR range, 350-1000nm
- ☐ UV-Visible-NIR range, 200-900nm
- ☐ NIR range, 900-1700 nm
- ☐ NIR-SWIR range, 900-2100 nm

Microspectroscopy Stages

- Manual XY
- ☐ Rotating & XY, 360deg/30mm x 40mm
- ☐ Semi-Rotating stage, up to 240deg
- ☐ Programmable XY Stage











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